



EMC Test Report

CE

Applicant :	Yuan Hsun Electric Co., Ltd.
Address of Applicant :	No. 57, Chung He Rd., Zuo-Ying Dist.,
	Kaohsiung city, 813 Taiwan, R.O.C.
Equipment Under Test :	Polarized Retro-Reflective Sensor
Model Number :	PBP-1000
Series :	N/A

Matrix Test Laboratory 2F, No.146, Jian Yi Rd., Chung-Ho City, Taipei Hsien, Taiwan, R.O.C. TEL. : +886 2 2228-6610 FAX. : +886 2 2228-6580

Contents

1	General Description	7
1.1	Description of EUT	7
1.2	Test Instruments	8
1.3	Auxiliary Equipments	10
1.4	Block Diagram	10
1.5	Identifying the Final Test Mode (Worst Case)	10
1.6	Final Test Mode	10
1.7	Condition of Power Supply	10
1.8	EUT Configuration	10
1.9	Test Facility	10
2	Conducted Emission Test	11
2.1	Test Instruments	11
2.2	Test Arrangement and Procedure	11
2.3	Conducted Limit	12
2.4	Test Result	12
3	Radiated Emission Test	15
3.1	Test Instruments	15
3.2	Test Arrangement and Procedure	15
3.3	Radiated Limit	15
3.4	Test Result	15
4	Harmonic Current Emission Measurement	18
4.1	Test Instruments	18
4.2	Test Configuration and Procedure	18
4.3	EUT Operation Condition	18
4.4	Test Limit	18
4.5	Test Result	19
5	Voltage Fluctuations and Flicker Measurement	21
5.1	Test Instruments	21
5.2	Test Configuration and Procedure	21
5.3	EUT Operation Condition	21
5.4	Test Limit	21
5.5	Test Result	21
6	Electrostatic Discharge Immunity Test	23
6.1	Test Instruments	23

	: R09071304E	Meririx
6.2	Test Configuration and Procedure	23
6.3	Compliance Criteria	24
6.4	Test Result	25
7	Radio-frequency, Electromagnetic Field Immunity Test	26
7.1	Test Instruments	26
7.2	Test Configuration and Procedure	26
7.3	Compliance Criteria	27
7.4	Test Result	27
8	Electrical Fast Transient Test	28
8.1	Test Instrument	28
8.2	Test Configuration and Procedure	28
8.3	Compliance Criteria	29
8.4	Test Result	29
9	Surge Immunity Test	30
9.1	Test Instrument	30
9.2	Test Configuration and Procedure	30
9.3	Compliance Criteria	30
9.4	Test Result	31
10	Radio-frequency, Conducted Disturbances Immunity Test	32
10.1	Test Instruments	32
10.2	Test Configuration and Procedure	32
10.3	Compliance Criteria	
		32
10.4	Test Result	32 33
10.4 11		
	Test Result	33
11	Test Result Voltage Dips, Short Interruptions Immunity Test	33 34
11 11.1	Test Result Voltage Dips, Short Interruptions Immunity Test Test Instrument	33 34 34
11 11.1 11.2	Test Result Voltage Dips, Short Interruptions Immunity Test Test Instrument Test Configuration and Procedure	33 34 34 34
11 11.1 11.2 11.3 11.4	Test Result Voltage Dips, Short Interruptions Immunity Test Test Instrument Test Configuration and Procedure Compliance Criteria	33 34 34 34 34
11 11.1 11.2 11.3 11.4	Test Result Voltage Dips, Short Interruptions Immunity Test Test Instrument Test Configuration and Procedure Compliance Criteria Test Result	33 34 34 34 34 35
11 11.1 11.2 11.3 11.4 12	Test Result Voltage Dips, Short Interruptions Immunity Test Test Instrument Test Configuration and Procedure Compliance Criteria Test Result Mains Supply Voltage Variations	33 34 34 34 34 35 36
11 11.1 11.2 11.3 11.4 12 12.1	Test Result Voltage Dips, Short Interruptions Immunity Test Test Instrument Test Configuration and Procedure Compliance Criteria Test Result Mains Supply Voltage Variations Test Instruments	33 34 34 34 35 36
11 11.1 11.2 11.3 11.4 12 12.1 12.2	Test Result Voltage Dips, Short Interruptions Immunity Test Test Instrument Test Configuration and Procedure Compliance Criteria Test Result Mains Supply Voltage Variations Test Instruments Test Instruments Test Configuration and Procedure	33 34 34 34 35 36 36 36
11 11.1 11.2 11.3 11.4 12 12.1 12.2 12.3	Test Result Voltage Dips, Short Interruptions Immunity Test Test Instrument Test Configuration and Procedure Compliance Criteria Test Result Mains Supply Voltage Variations Test Instruments Test Configuration and Procedure Compliance Criteria	33 34 34 34 35 36 36 36 36
11 11.1 11.2 11.3 11.4 12 12.1 12.2 12.3 12.4	Test Result Voltage Dips, Short Interruptions Immunity Test Test Instrument Test Configuration and Procedure Compliance Criteria Test Result Mains Supply Voltage Variations Test Instruments Test Configuration and Procedure Compliance Criteria Test Result	33 34 34 34 35 36 36 36 36 36 36 37
11 11.1 11.2 11.3 11.4 12 12.1 12.2 12.3 12.4 13	Test Result Voltage Dips, Short Interruptions Immunity Test Test Instrument Test Configuration and Procedure Compliance Criteria Test Result Mains Supply Voltage Variations Test Instruments Test Configuration and Procedure Compliance Criteria Test Result Photographs of Test	33 34 34 34 35 36 36 36 36 36 37 38

Report No.: R09071304E	Mehirix
13.4 Electrostatic Discharge Immunity Test	40
13.5 Radio-frequency, Electromagnetic Field Immunity Test	41
13.6 Electrical Fast Transient / Burst Immunity Test	41
13.7 Surge Immunity Test	42
13.8 Radio-frequency, Conducted Disturbances Immunity Tes	t 42
13.9 Voltage Dips, Short Interruptions Immunity Test	43
13.10 Mains Supply Voltage Variations	43
14 Photographs of EUT	44
15 Photographs of ESD Test Points	48

Ve	rification		
Applicant :	Yuan Hsun Electric Co., Ltd.		
Manufacturer :	Yuan Hsun Electric Co., Ltd.		
Equipment Under Test:	Polarized Retro-Reflective Sensor		
Model Number :	PBP-1000		
Series :	N/A		
Sample Received Date :	2009-07-13		
Test Standard :			
Emission:	Immunity:		

Remark:

This report details the results of the tests carried out on one sample. This report shows the EUT is technically compliant with EN 55022 and EN 50130-4 official requirements. This report applies to the above sample only and shall not be reproduced in part without written approval of Matrix Test Laboratory.

lody Peng Documented by: Date: 2009-08-11 Jody Peng/ ADM. Dept. Staff Kenny Yang 2009-08-10 Tested by: Date: Kenny Yang/ ENG. Dept. Staff 2009-08-11 Approved by: Date: Peter Chin/ Head of Laboratory



Summery of Test Result

Emission							
Test Standard	Test Item	Test Result	Remark				
EN55022	Conducted Emission	Pass	Highest Emission L: 0.183MHz, Q.P.47.67dBuV, Margin -6.56 dB, A.V.40.25dBuV, Margin -3.98 dB, N: 0.184MHz, Q.P.48.18dBuV, Margin -6.03 dB, A.V.40.49dBuV, Margin -3.72 dB,				
EN55022	Radiated Emission	Pass	Highest Emission H: 34.85MHz, 31.45dBuV, Margin-4.69 dB Antenna Height 3 m, Turntable Angle 208° V: 37.76MHz, 32.56dBuV, Margin-4.94 dB Antenna Height 1 m, Turntable Angle 241°				
EN61000-3-2	Harmonic	Pass	Refer to Page 19				
EN61000-3-3	Flicker	Pass	Refer to Page 21				

Immunity						
Test Standard	Test Item	Test Result				
IEC61000-4-2	Electrostatic Discharge	Pass				
IEC61000-4-3	Radiated Susceptibility	Pass				
IEC61000-4-4	Electrical Fast Transient	Pass				
IEC61000-4-5	Surge	Pass				
IEC61000-4-6	Conducted Susceptibility	Pass				
IEC61000-4-11	Voltage Dips and Interruption	Pass				
EN50130-4	Mains Supply Voltage Variations	Pass				



1 General Description

1.1 Description of EUT

Equipment Under Test	:	Polarized Retro-Reflective Sensor
Model Number	:	PBP-1000
Series	:	N/A
Applicant Address of Applicant	:	Yuan Hsun Electric Co., Ltd. No. 57, Chung He Rd., Zuo-Ying Dist., Kaohsiung city, 813 Taiwan, R.O.C.
Manufacturer Address of Manufacturer	:	Yuan Hsun Electric Co., Ltd. No. 57, Chung He Rd., Zuo-Ying Dist., Kaohsiung city, 813 Taiwan, R.O.C.
Power Supply	:	AC 230V, 50Hz
Data Cable	-	⊠N/A
Description of EUT	-	Dimensions : 11.5 cm (L) X 5.2 cm (W) X 5.4 cm (H) Weight : 120 g Test Position : ⊠Table-top / □Floor-standing Intended Function : The EUT is a Polarized Retro-Reflective Sensor.

1.2 Test Instruments

Instruments Used for Emission Measurement

Instrument	Manufacturer	Model	Serial No.	Calibration Date	Application
L.I.S.N.	Mess Tec	NNB-2/16Z	03/1006	2009-05-12	Conducted Emission
L.I.S.N.	EMCIS	LN2-16	LN04023	2009-01-16	Conducted Emission
Pulse Limiter	Mess Tec	PL10	N/A	2009-02-23	Conducted Emission
RF Cable	N/A	N/A	N/.A	2009-05-11	Conducted Emission
EMI Receiver	R&S	ESCI	100615	2009-02-27	Conducted Emission Radiated Emission
Bilog Antenna	Teseq GmbH	CBL6111D	25769	2009-02-19	Radiated Emission
Pre-Amplifier	Schaffner	CPA9231A	N/A	2009-07-20	Radiated Emission
Spectrum Analyzer	HP	8595E	3829A03763	2009-07-19	Radiated Emission
Spectrum Analyzer	R & S	FSL6	100564	2008-12-05	Radiated Emission
RF Cable	MIYAZAKI	8D-F8	N/A	2009-07-20	Radiated Emission
Programmable AC Source	Chroma	6520	2048	2009-02-06	Harmonic, Flicker
Universal Power Analyzer	Chroma	6630	0597	2009-02-06	Harmonic, Flicker

Note: The instruments listed above are within their calibration period of 1 year.



Instruments Used for Immunity Measurement

Instrument	Manufacturer	Model	Serial No.	Calibration Date	Application
ESD Simulator	Noiseken	TC-815R	ESS0868491	2008-12-12	Electrostatic Discharge
ESD Simulator	Noiseken	ESS-2002EX	ESS0868406	2008-12-12	Electrostatic Discharge
Antenna	FRANKONIA	BTA-H	030001H	2009-08-03	Radiated Immunity
Field Probe	EMCO	7201	N/A	2008-10-23	Radiated Immunity
Power Amplifier	IFI	CMX50	N/A	2008-10-23	Radiated Immunity
Signal Generator	R&S	SML03	103396	2008-10-23	Radiated Immunity
CDN	FRANKONIA	CDN M2+M3	A3011037	2008-10-23	Conducted Immunity
C.I. Test System	FRANKONIA	CIT-10/75	102C3208	2008-10-23	Conducted Immunity
Power Attenuator	FRANKONIA	75-A-FFN-06	0212	2008-11-07	Conducted Immunity
RF Cable	N/A	N/A	N/.A	2009-05-07	Conducted Immunity
Antenna	EMC PARTNER	MF-1000-1	119	2008-11-04	Magnetic Field Disturbance
Transient 2000	EMC PARTNER	TRA-2000	449	2008-11-04	Electrostatic Discharge, Fast Transient, Surge, Magnetic Field Disturbance, Dips & Interruptions

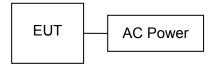
Note: The instruments listed above are within their calibration period of 1 year.



1.3 Auxiliary Equipments

N/A

1.4 Block Diagram



1.5 Identifying the Final Test Mode (Worst Case)

- 1. Stand by Mode
- 2. Operation Mode

Note: After pre-test, we identified that the Operation Mode (the worst case) was most likely to cause maximum disturbance and most likely to be susceptible to disturbance. Therefore, the Final EMC Assessment was performed for the worst case.

1.6 Final Test Mode

Operation Mode

1.7 Condition of Power Supply

AC 230V, 50Hz

1.8 EUT Configuration

- 1. Setup the EUT as shown in Sec.1.4 Block Diagram.
- 2. Turn on the power of all equipments.
- 3. Activate the main function(s) of the EUT.

1.9 Test Facility

Site Description	•	Il tests are completed by Matrix Test Laboratory. Radiated emissic performed at HongAn's open-site.		
Name of Firm	:	Matrix Test Laboratory		
Site Location	:	2F, No.146, Jian Yi Rd., Chung-Ho City, Taipei Hsien, Taiwan, R.O.C.		

1.9.1 Test Methodology

All Emission Tests were performed according to the procedures specified in EN55022 and EN 50130-4. Radiated Emission Test was performed at 10 m distance from antenna to EUT. All Immunity Tests were performed according to the general standards specified in EN 50130-4.

2 Conducted Emission Test

2.1 Test Instruments

Refer to Sec. 1.2 Test Instruments.

2.2 Test Arrangement and Procedure

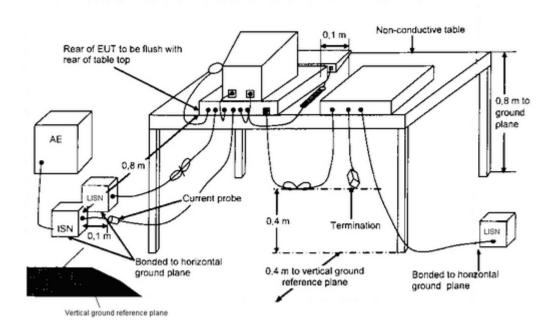


Table-top Equipment

- The EUT was placed on a non-conductive table which was 80 cm above the horizontal coupling plane. The rear of the EUT was 40 cm from the vertical coupling plane.
- The excess interface cables were folded at the cable center into a bundle no longer than 40 cm, so that the bundles were on the table.
- The EUT was connected to the main power through a L.I.S.N. This set up provided 50 ohm / 50 μH coupling impedance for the measuring equipment.
- All auxiliary equipment received power from a second L.I.S.N.
- The conducted emissions were measured between the Line Phase and the PE ground and between the Neutral Phase and the PE ground using an EMI Receiver.
- The values were recorded.

Report No.: R09071304E

2.3 Conducted Limit

EN 55022

		ass A	🖂 Class B	
Frequency (MHz) Q.P. (Quasi-Pea		A.V. (Average)	Q.P. (Quasi-Peak)	A.V. (Average)
0.15 ~ 0.50	79	66	66 to 56	56 to 46
0.50 ~ 5.0	73	60	56	46
5.0 ~ 30	73	60	60	50

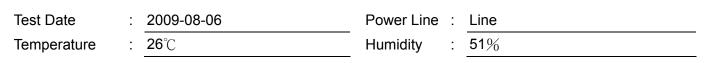
The EMI Receiver bandwidth was set at 9 kHz.

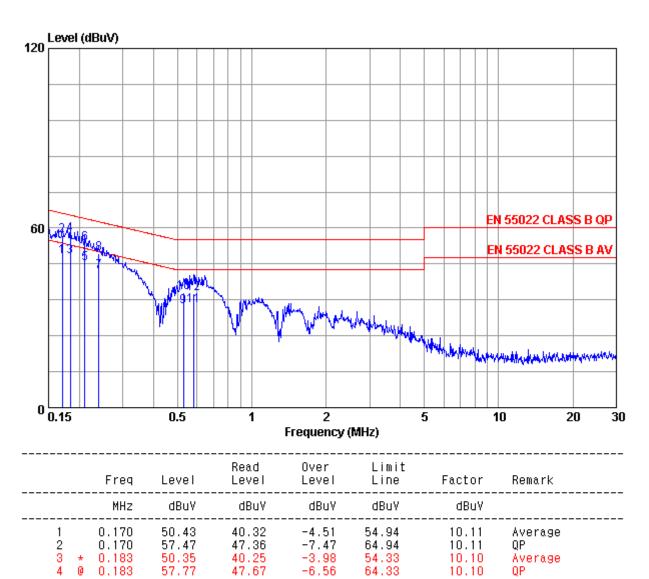
2.4 Test Result

PASS

The final test data are shown on the following page(s).

Conducted Emission Test Data





-6.56

-5.09

-8.19

-6.72

-10.58

-12.23

-17.67

-11.84

-18.01

64.33

53.18

63.18

52.08

62.08

46.00

56.00

46.00

0.582 37.99 27.87 56.00 10.12 Level(dBuV) = Read Level(dBuV) + Factor(dBuV) Factor(dBuV) = LISN Factor(dBuV) + Cable Loss(dBuV) + PLUSE Limter(dBuV) @ :Maximum QP * :Maximum AVG - x :Over Limit !:Over Margin Red Point(or Red Trace) For Average Detector Green Point(or Green Trace) For Quasipeak Detector

37.99

44.89

35.26

41.40

23.65

28.21

24.04

R&S_ESCI Receiver : MessTec NNB - 2/16 Z LISN : Pluse Limiter : MessTec PL10

57.77

48.09

54.99

45.36

51.50

33.77

38.33

34.16

4

5

6

7

8

9

10

11

12

0.183

0.211

0.211

0.240

0.240

0.529

0.529

0.582

QP

QP

QP

QP

QP

Average

Average

Average

Average

10.10

10.10

10.10

10.10

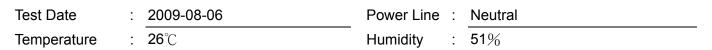
10.10

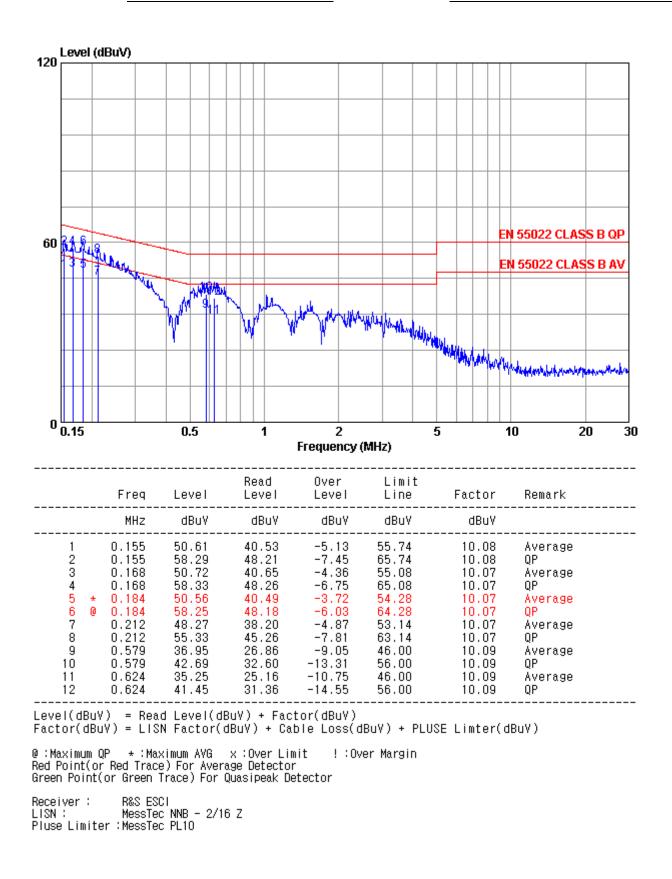
10.12

10.12

10.12

Conducted Emission Test Data





3 Radiated Emission Test

3.1 Test Instruments

Refer to Sec. 1.2 Test Instruments.

3.2 Test Arrangement and Procedure

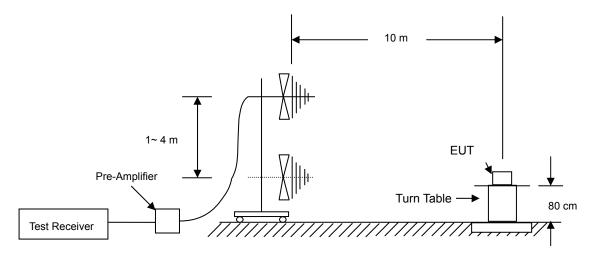


Table-top Equipment

- The EUT was place on a non-conductive turntable which was 80 cm above the horizontal ground plane. The EUT was set 10 m away from the receiving antenna that was mounted on a non-conductive mast.
- Main cables draped to the ground plane and were routed to the mains power outlet.
 The mains power outlet was bonded to and did not protrude above the ground plane.
- The antenna was adjusted between 1 m and 4 m in height above the ground plane and the Antenna-to-EUT azimuth was also varied during the measurements to find the top 6 maximum meter readings within the frequency range limit as indicated in Sec 3.3.
- The radiated emissions were measured when the Antenna-to-EUT polarization was set horizontally and vertically.
- The values were recorded.

3.3 Radiated Limit

EN 55022

Frequency (MHz)	🗌 Class A	🛛 Class B	
	Quasi-Peak (dBuV/m)	Quasi-Peak (dBuV/m)	
30 ~ 230	40.0	30.0	
230 ~ 1000	47.0	37.0	

The EMI test receiver bandwidth was set at 120 kHz.

3.4 Test Result

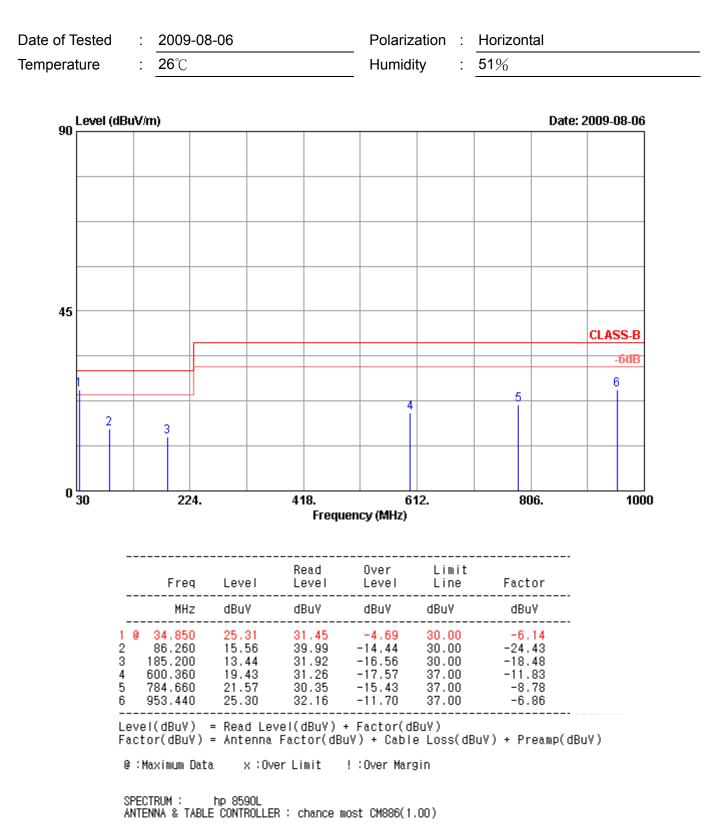
PASS

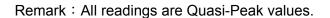
The final test data are shown on the following page(s).





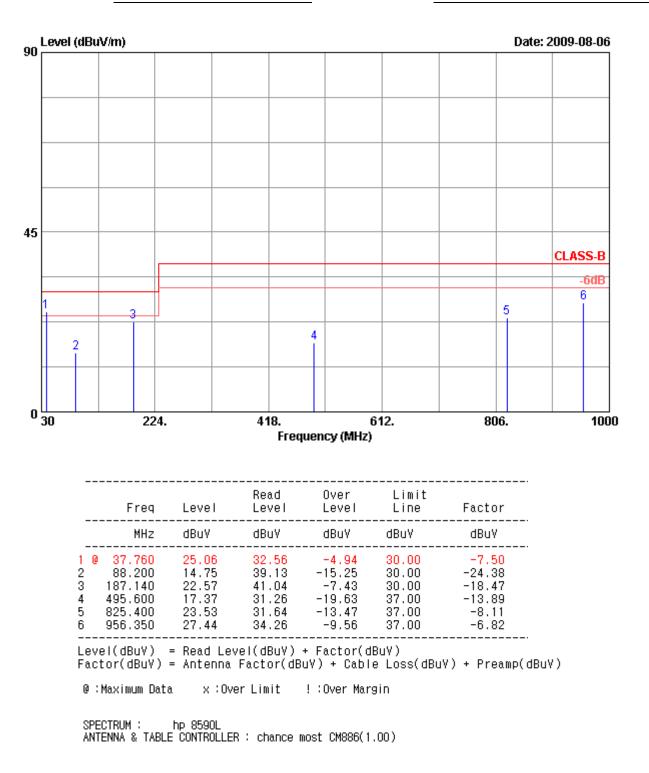
Radiated Emission Test Data





Radiated Emission Test Data

Date of Tested	:	2009-08-06	Polarization	:	Vertical
Temperature	:	26 ℃	Humidity	:	51%



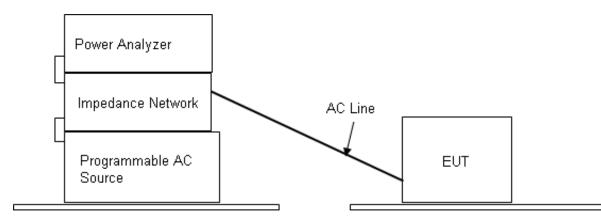
Remark : All readings are Quasi-Peak values.

4 Harmonic Current Emission Measurement

4.1 Test Instruments

Refer to Sec. 1.2 Test Instruments.

4.2 Test Configuration and Procedure



- The EUT was set in series with the Power Analyzer through an Impedance Network for the measurement of harmonic currents.
- The supply voltage and frequency setting on the Programmable AC Source was programmed as the rated voltage and frequency of the EUT.
- Classify the EUT class in accordance with the IEC61000-3-2 for the purpose of harmonic current limitation. The measurement was automatically performed by test software. The test result was collected and analyzed by the computer.

4.3 EUT Operation Condition

Environment Condition

Temperature	Humidity	Atmospheric Pressure
28 ℃	44%RH	1008mbar

4.4 Test Limit

Harmonic Order (n)	Maximum permissible harmonic current (A)			
Odd harmonics				
3	2.30			
5	1.14			
7	0.77			
9	0.40			
11	0.33			

Report No.: R09071304E



13	0.21			
15 ≤ n ≤ 39	0.15 * 15 / n			
Even harmonics				
2	1.08			
4	0.43			
6	0.30			
8 ≤ n ≤ 40	0.23 * 8 / n			

4.5 Test Result

PASS

The measured result is shown on the following page(s).

Chron	na		ANALS	YZER 663	0		2009.07.1	5 11:22:14
Setup: CLASS		rent			nic 229.8		: 50.000 Hz	Next measure
Live Module: M1	Anal Limi Note	ysed per t: Class	iods: A (E	4 I:	0.632 14)	24 A P:	126.5 ₩ : 0.5622 A	Change to bar graph
No	A Lim A	No	Ĥ	Lim A	No	Ĥ	Lim A	Relative current
1 0.56	Z	15 0.	008	0.150	29	0.004	0.078	
2 0.00	7 1.081	16 Ø.	000	0.115	30	0.000	0.061	
3 0.20	0 2.301	17 0.	017	0.132	31	0.012	0.073	
4 0.00	2 0.430	18 Ø.	000	0.102	32	0.000	0.058	
5 0.14	6 1.141	19 Ø.	006	0.118	33	0.008	0.068	
6 0.00	1 0.300	20 0.	001	0.092	34	0.000	0.054	Write to
7 0.12	2 0.770	21 Ø.	014	0.107	35	0.009	0.064	disk
8 0.00	1 0.230	ZZ Ø.	001	0.084	36	0.000	0.051	aisk
9 0.06	20.400	23 Ø.	008	0.098	37	0.006	0.061	
10 0.00	1 0.184	24 Ø.	000	0.077	38	0.000	0.048	
11 0.03	0 0.330	25 Ø.	013	0.090	39	0.015	0.058	
12 0.00	0 0.153	26 Ø.	000	0.071	40	0.000	0.046	
13 0.02	7 0.210	27 Ø.	001	0.083				
14 0.00	1 0.132	28 Ø.	000	0.066				
Current rang	e: 3Ap							
						Appl: C	LASS A&B	(1212_00)
<u>Chron</u>	nđ		ANALY	YZER 663	0		2009.07.1	5 11:23:10
	<u> </u>							

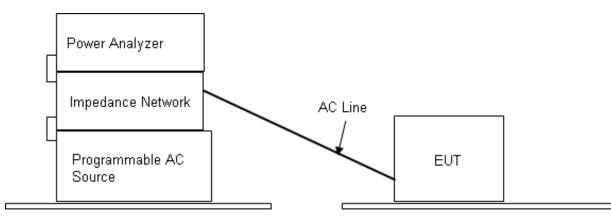
	Next
Setup: CLASS A Gen setting: 1(1) U : 229.88 V fu: 50.000 Hz Live Analysed periods: 4 I : 0.6324 A P: 126.5 W Module: M1 Limit: Class A (EN61000_A14) I1: 0.5622 A Note: THD=51.30 % (PF=0.870) PASSED	measure Change to table
A] ★	Relative current
2.00 · · · · · · · · · · · · · · · · · ·	Log scale
1.00	Write to disk
0 2 4 6 8 10 12 14 16 18 20 22 24 26 28 30 32 34 36 38 40 Harmonic order Appl: CLASS A&B	(1212_01)

5 Voltage Fluctuations and Flicker Measurement

5.1 Test Instruments

Refer to Sec. 1.2 Test Instruments.

5.2 Test Configuration and Procedure



- The EUT was set in series with the Power Analyzer through an Impedance Network for the measurement of Flicker Voltage.
- The supply voltage and frequency setting on the Programmable AC Source was programmed as the rated voltage and frequency of the EUT.
- The measurement was automatically performed by test software. The test result was collected and analyzed by the computer.

5.3 EUT Operation Condition

Environment Condition

Temperature	Humidity	Atmospheric Pressure
28 ℃	44%RH	1008mbar

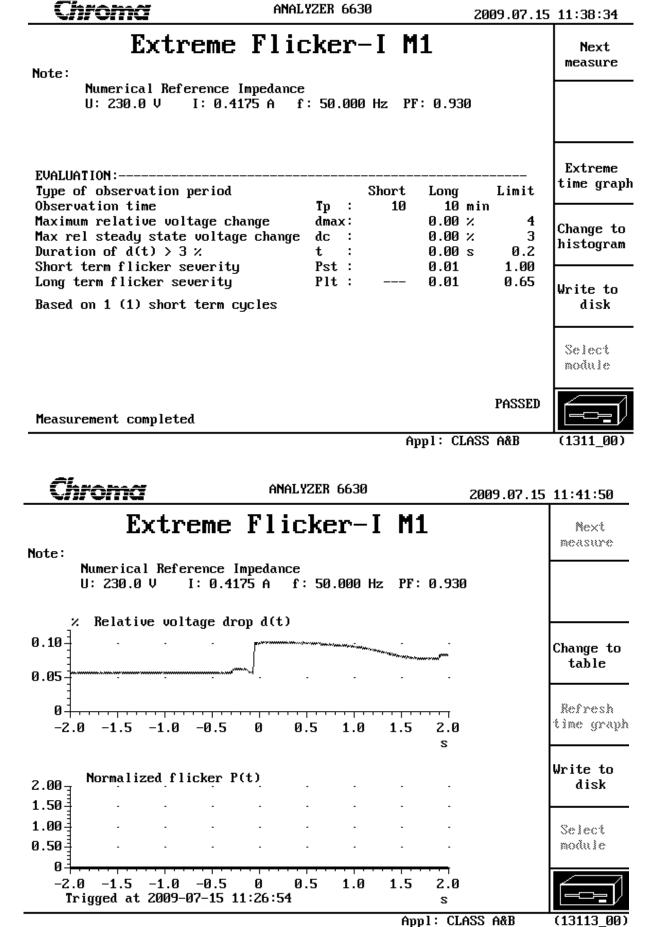
5.4 Test Limit

Test Item	Limit	Remark
Pst	1.0	Pst means short-term flicker indicator. T_p =10 min
Pit	0.65	Pit means long-term flicker indicator. $T_p=2$ hrs
dt (%)	3.3	For more than 500ms
dmax (%)	4	dmax means relative maximum voltage change.
dc (%)	3.3	dc means relative steady-state voltage change.

5.5 Test Result

PASS

The measured result is shown on the following page(s).



Report No.: R09071304E



Marrix

6 Electrostatic Discharge Immunity Test

6.1 Test Instruments

Refer to Sec. 1.2 Test Instruments.

6.2 Test Configuration and Procedure

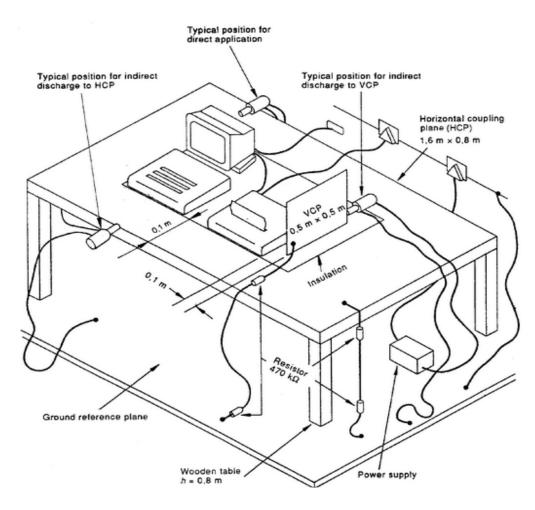


Table-top Equipment

- A functional test was performed before the conditioning.
- The EUT was located on a 0.8 m high wooden table standing on the ground reference plane with a 1.6 * 0.8 m horizontal coupling plane on the top. The EUT and cables was isolated from the coupling plane by an insulating support 0.5 mm thick.
- In Contact Discharge, the EUT was exposed to 10 single discharges (the selected test points were marked with red labels on the EUT)
- In Air Discharge, the EUT exposed to minimum of 10 single discharges on the selected test points.
- The EUT was monitored during the conditioning period.
- After the conditioning, a functional test was performed. The EUT was inspected visually for any mechanical damage.

There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the application of the discharges is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change. And there shall be no change in the functioning of the EUT and no significant change in any measurement, which shall also remain within specification.

6.4 Test Result

6.4.1 Environment Condition

Temperature	Humidity	Atmospheric Pressure	
28 °C	44%RH	1008mbar	

6.4.2 Observation of Direct Discharge

Test Points: 1. Surface of Case. 2. Junction of Case.

Type of Discharge	Test Level	Polarity	Test Point	Number of Discharge	Verdict			
Air Discharge	2,4,8 (kV)	2,4,8 (kV) ± 1~2 20/ per point Pass						
Contact Discharge	2,4,6 (kV) ± 1 20/ per point							
Remarks1. No damage, malfunction or change of status has been observed during the conditioning and throughout the entire functional test.								
No damage, malfunction or change of status has been observed during the conditioning and throughout the entire functional test.								

6.4.3 Observation of Indirect Discharge

Test Points: 1. Front Side. 2. Rear Side. 3. Left Side. 4. Right Side.

Type of Discharge	Test Level	Polarity	Test Point	Number of Discharge	Verdict
HCP	2,4,6 (kV)	±	1~4	20/ per point	Pass
Application	2,4,0 (KV)	-	1/~4		F 855
VCP	2,4,6 (kV)	±	1~4	20/ per point	Pass
Application	2,4,0 (KV)	<u>-</u>	1/~4		F 855
Remarks	1. No damage, malfunction or change of status has been observed during the				
	conditioning and throughout the entire functional test.				
	2. No damage, malfunction or change of status has been observed during the				
	conditioning and throughout the entire functional test.				

PASS

The test result shows that the EUT is in compliance with the test performance criteria specified in EN 50130-4.

7 Radio-frequency, Electromagnetic Field Immunity Test

7.1 Test Instruments

Refer to Sec. 1.2 Test Instruments.

7.2 Test Configuration and Procedure

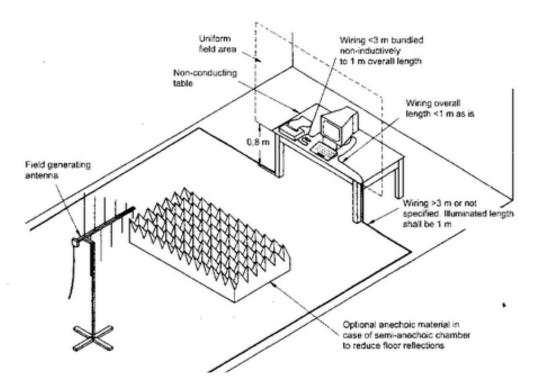


Table-top Equipment

- A functional test was performed before the conditioning.
- The field calibration was executed to create a uniform field area (UFA), 3 m away from the antenna, to ensure the validity of the test results.
- The EUT was placed on a non-conductive table 0.8 m high in the UFA.
- The EUT was then connected to power and signal wires according to relevant installation instruction.
- The EUT was positioned so that the four sides of the EUT were exposed to the electromagnetic field in sequence. In each position, the performance of the EUT was investigated and monitored by a CCD camera..
- The EUT was monitored during the conditioning period.
- After the conditioning, a functional test was performed. The EUT was inspected visually for any mechanical damage.



7.3 Compliance Criteria

There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the conditioning is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as change, and no such flickering of indicators occurs at a field strength of 3V/m.

7.4 Test Result

7.4.1 Environment Condition

Temperature	Humidity	Atmospheric Pressure
28 ℃	44%RH	1008mbar

7.4.2 Observation of Test

	Test Specifications				
Type of Modulation	Field Strength	Frequency Range	Modulation	Verdict	
Amplitude Modulation	10V/m	80 to 2000MHz	80%, 1kHz, Sinusoidal	Pass	
Pulse Modulation	10V/m	80 to 2000MHz	1Hz (0.5s On: 0.5s Off)	Pass	
Remark	1. No damage, malfunction or change of status has been observed during the				
	conditioning and throughout the entire functional test.				
	No damage, malfunction or change of status has been observed during the conditioning and throughout the entire functional test.				

PASS

The test result shows that the EUT is in compliance with the test performance criteria specified in EN 50130-4.

8 Electrical Fast Transient Test

8.1 Test Instrument

Refer to Sec. 1.2 Test Instruments.

8.2 Test Configuration and Procedure

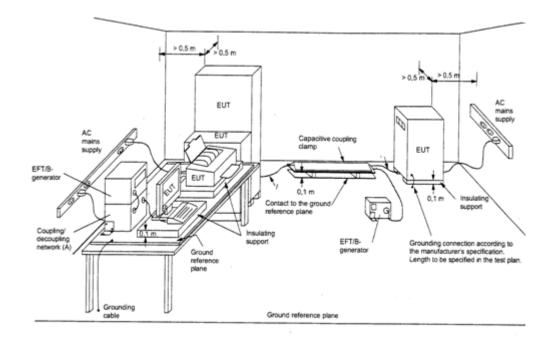


Table-top Equipment

- The EUT was placed on a table of 0.8 m height above the 1 * 1 m metallic ground reference plane, which projected beyond the EUT by at least 0.1 m on all sides.
- The ground plane was connected to the protective earth.
- The distance between the EUT and all other conductive structures, except the ground plane beneath the EUT was more than 0.5 m.
- The length of the signal and power lies between the coupling device and the EUT was 0.5 m.
- All cables to the EUT were placed on the insulation support 0.1 m above the ground reference plane.
- The EUT was connected to the power mains through a coupling device that directly coupled the EFT interference signal. Each of the Line, Neutral and Protective Earth conductors was injected with burst for 1 minute. The test time was broken down into six 10 s bursts separated by a 10 s pause for avoiding synchronization. Both voltage polarities were applied for each test level.
- Operating condition was shown on the monitor and observed.

8.3 Compliance Criteria

There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the application of the bursts is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change. And there shall be no change in the functioning of the EUT and no significant change in any measurement, which shall also remain within specification.

8.4 Test Result

8.4.1 Environment Condition

Temperature	Humidity	Atmospheric Pressure
28 ℃	44%RH	1008mbar

8.4.2 Observation of Power Supply Port

Coupling					
Coupling Selection	Voltage (k)/)	Test Duration	Repetition	Tr/ Td	Verdict
Selection	Voltage (kV)	(Sec)	Rate (kHz)	(nS)	
L	±2	60	1	5/50	Pass
N	±2	60	1	5/50	Pass
PE	±2	60	1	5/50	Pass
L + N	±2	60	1	5/50	Pass
L + PE	±2	60	1	5/50	Pass
N + PE	±2	60	1	5/50	Pass
L + N +PE	±2	60	1	5/50	Pass
Remark	No damage, malfunction or change of status has been observed during the				
	conditioning and throughout the entire functional test.				
Note	Phase Shifting:0°,90°,180°,270°,360°				

8.4.3 Observation of Signal Lines (Applicable only to cable length > 3m)

The cable connected to the EUT in the test was not longer than 3m. Therefore, no test has been required.

PASS

The test result shows that the EUT is in compliance with the test performance criteria specified in EN 50130-4.

Merrix

9 Surge Immunity Test

9.1 Test Instrument

Refer to Sec. 1.2 Test Instruments.

9.2 Test Configuration and Procedure

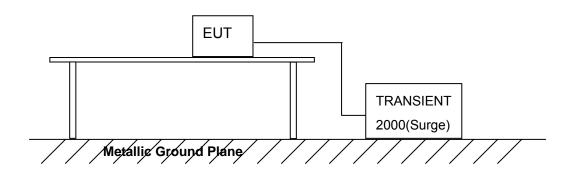


Table-top Equipment

- The EUT was placed on a table of 0.8 m height above the 1 * 1 m metallic ground reference plane, which projected beyond the EUT by at least 0.1 m on all sides.
- The ground plane was connected to the protective earth.
- The length of power cord between the coupling device and the EUT is less than 2 m (provided by the manufacturer).
- The EUT was connected to the power mains through a coupling device that directly couples the Surge interference signal. The surge noise was applied synchronized to the voltage phase at the zero crossing and the peak value of the AC voltage wave (positive and negative).
- The surges were applied line to line and line(s) to earth. When testing line to earth, the test voltage was applied successively between each of the lines and earth. Steps up to the test level specified increased the test voltage. All lower levels including the selected test level were tested. The polarity of each surge level included positive and negative test pulses.
- Operating condition was shown on the monitor and observed.
- After the conditioning, a functional test was performed. The EUT was inspected visually for any mechanical damage.

9.3 Compliance Criteria

There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the application of the surges is permissible, providing that there is no residual change in the EUT or any change in outputs, which could e interpreted by associated equipment as a change. And there shall be no change in the functioning of the EUT and no significant change in any measurement, which shall also remain within specification.

9.4 Test Result

9.4.1 Environment Condition

Temperature	Humidity	Atmospheric Pressure
28 ℃	44%RH	1008mbar

9.4.2 Observation of Power Supply Port

	Test Specifications				
Coupling	Voltago (k)/)	Min. of Surge	Repetition Rate	Verdict	
Selection	Voltage (kV)	at Each Polarity	(per min)	Verdict	
L►N	±0.5, 1	20	< 1	Pass	
L ►PE	±0.5, 1, 2	20	< 1	Pass	
N ►PE	±0.5, 1, 2	20	< 1	Pass	
Remark	No damage, malfunction or change of status has been observed during the				
conditioning and throughout the entire functional test.					

9.4.3 Observation of Signal Lines (Applicable only to cable length > 30m)

The cable connected to the EUT in the test was not longer than 30m. Therefore, no test has been required.

PASS

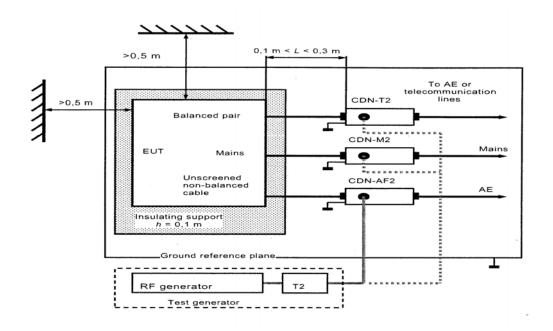
The test result shows that the EUT is in compliance with the test performance criteria specified in EN 50130-4.

10 Radio-frequency, Conducted Disturbances Immunity Test

10.1 Test Instruments

Refer to Sec. 1.2 Test Instruments.

10.2 Test Configuration and Procedure



- The EUT was placed on an insulating support of 0.1 m height above a ground reference plane. All cables exiting the EUT was supported at a height of 30 mm above the ground reference plane.
- The EUT was connected to the power mains through a Coupling and Decoupling Networks (CDN).
- The CDN was located 0.3 m from the EUT as indicated in the diagram above.
- The test was performed with the test generator connected to each of the CDN in turn while the other non-excited RF input ports of the coupling devices were terminated by a 50 Ω terminator.
- The conducted disturbance was applied on the EUT from 150 kHz to 100 MHz using the signal levels established during the setting process.
- Operating condition was shown on the monitor and observed.

10.3 Compliance Criteria

There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the conditioning is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change, and no such flickering of indicators occurs at U0=130dBµV.





And there shall be no change in the functioning of the EUT and no significant change in any measurement, which shall also remain within specification.

10.4 Test Result

10.4.1 Environment Condition

Temperature	Humidity	Atmospheric Pressure	
28 °C	44%RH	1008mbar	

10.4.2 Observation of Test

	Test Specifications			
Type of	Voltage Level	Frequency	Modulation	Verdict
Modulation	(emf) U_0	Range	Wooulation	verdict
Amplitude Modulation	10V/ 140dBµV	0.15 to 100MHz	80%, 1kHz, sinusoidal	Pass
Pulse Modulation	10V/ 140dBµV	0.15 to 100MHz	1Hz (0.5s On: 0.5s Off)	Pass
Remark	No damage, malfunction or change of status has been observed during the			
	conditioning and throughout the entire functional test.			
Note	Phase Shifting:0°,9	90°,180°,270°,360°		

10.4.3 Observation of Signal Lines (Applicable only to cable length > 3m)

The cable connected to the EUT in the test was not longer than 3m. Therefore, no test has been required.

PASS

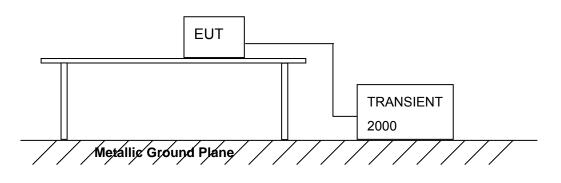
The test result shows that the EUT is in compliance with the test performance criteria specified in EN50130-4.

11 Voltage Dips, Short Interruptions Immunity Test

11.1 Test Instrument

Refer to Sec. 1.2 Test Instruments.

11.2 Test Configuration and Procedure



- A functional test was performed before the conditioning.
- The EUT was tested with (I) 30% voltage reduction (II) 60% voltage reduction (III) 100% voltage reduction with different time duration as indicated on the following page.
- During the conditioning period, the EUT status was monitored.
- After the conditioning, the EUT was inspected visually for any mechanical damage.

11.3 Compliance Criteria

There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the conditioning is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change. And there shall be no change in the functioning of the EUT and no significant change in any measurement, which shall also remain within specification.



11.4 Test Result

Merrix

11.4.1 Environment Condition

Temperature	Humidity	Atmospheric Pressure
28 ℃	44%RH	1008mbar

11.4.2 Observation of Power Supply Port

Voltage Dips

	Test Specifications				
Voltage	Duration Periods	No. of	Interval between Each	Verdict	
Reduction (%)	Duration Ferious	Reductions	Duration (Second)	veruici	
30	0.5,1,5,10	3	≥ 10	Pass	
60	0.5,1,5,10	3	≥ 10	Pass	
100	0.5,1,5	3	≥ 10	Pass	
Remarks	1. No damage, malfunction or change of status has been observed during the				
	conditioning and throughout the entire functional test.				
	2. No damage, malfunction or change of status has been observed during the				
	conditioning and throughout the entire functional test.				
	3. No damage, malfunction or change of status has been observed during the				
	conditioning and throughout the entire functional test.				
Note	Phase Shifting:0°,90°,180°,270°,360°				

PASS

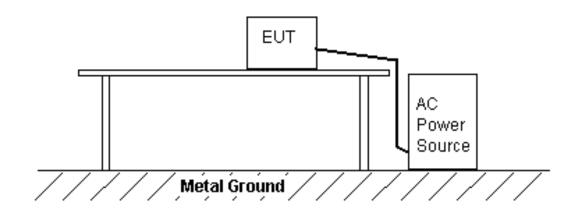
The test result shows that the EUT is in compliance with the test performance criteria specified in EN 50130-4.

12 Mains Supply Voltage Variations

12.1 Test Instruments

Refer to Sec. 1.2 Test Instruments.

12.2 Test Configuration and Procedure



- A functional test was performed before the conditioning.
- The EUT was exposed to (I) the maximum power supply condition (Nominal Mains Voltage + 10%) (II) the minimum power supply condition (Nominal Mains Voltage 15%) until temperature stability was reached.
- During the conditioning, the EUT status was monitored.
- A functional test was performed after each conditioning once the temperature stability was obtained.
- After the conditioning, a functional test was performed. The EUT was inspected visually for any mechanical damage.

12.3 Compliance Criteria

There shall be no damage, malfunction or change of status due to the different supply voltage conditions. And there shall be no change in the functioning of the EUT and no significant change in any measurement, which shall also remain within specification.

12.4 Test Result

12.4.1 Environment Condition

Temperature	Humidity	Atmospheric Pressure
28 ℃	44%RH	1008mbar

12.4.2 Observation of Power Supply Port

Voltage Variance

Supply Voltage			Verdict	
Supply Voltage Max. =		253V	Pass	
Nominal Mains Voltage + 10%				
Supply Voltage Min. =		195.5V	Pass	
Nominal Mains Voltage - 15%				
Remarks	No damage, malfunction or change of status has been observed during the			
conditioning and throughout the entire functional test.				

PASS

The test result shows that the EUT is in compliance with the test performance criteria specified in EN 50130-4.

13 Photographs of Test

13.1 Power Line Conducted Test



Front View



Rear View

13.2 Radiated Emission Test





Front View

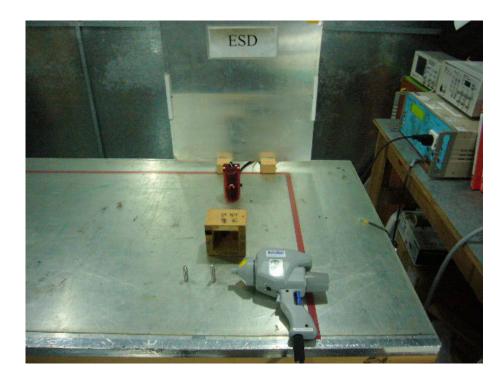


Rear View

13.3 Harmonic Current & Voltage Fluctuations and Flicker Measurement



13.4 Electrostatic Discharge Immunity Test



13.5 Radio-frequency, Electromagnetic Field Immunity Test



13.6 Electrical Fast Transient / Burst Immunity Test

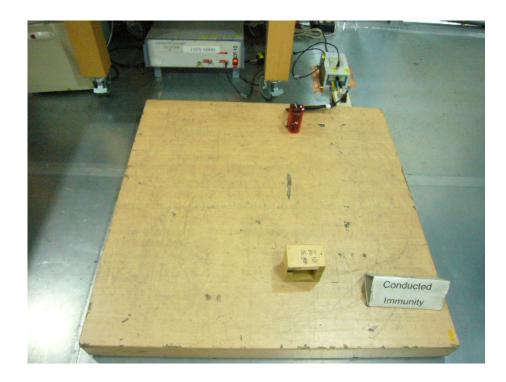




13.7 Surge Immunity Test

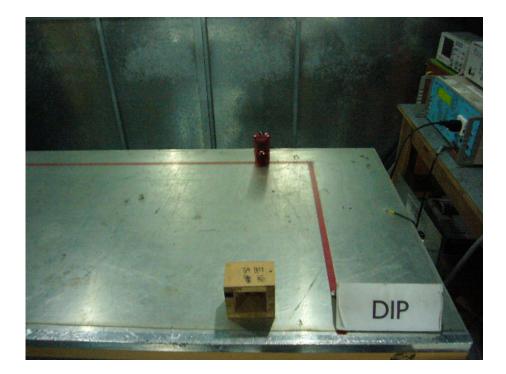


13.8 Radio-frequency, Conducted Disturbances Immunity Test





13.9 Voltage Dips, Short Interruptions Immunity Test



13.10 Mains Supply Voltage Variations







Front View of the EUT

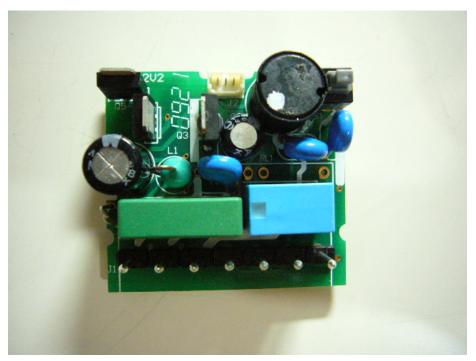


Rear View of the EUT

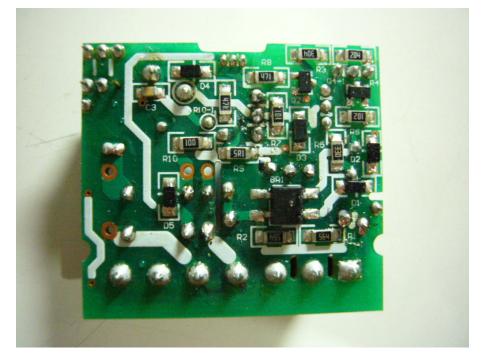




Inside View of the EUT



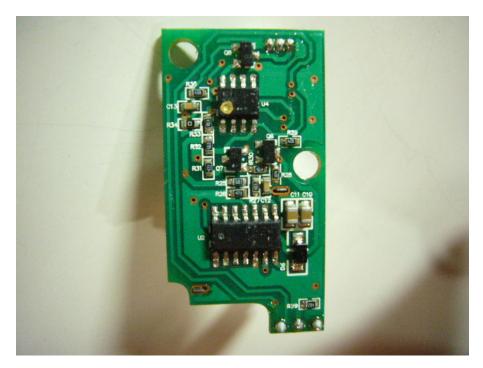
Front View of the PCB 1-1



Rear View of the PCB 1-2



Front View of the PCB 2-1



Rear View of the PCB 2-2



15 Photographs of ESD Test Points



View of ESD Test Points



View of ESD Test Points





View of ESD Test Points